

**Notice of References Cited**

Application/Control No.

10/580,484

Applicant(s)/Patent Under  
Reexamination  
HAMMELL, BRADLEY R.

Examiner

OLUSEYE IWARERE

Art Unit

3687

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,212,829 B1	05-2007	Lau et al.	455/456.1
*	B	US-2004/0024644 A1	02-2004	Gui et al.	705/22
*	C	US-2002/0032612 A1	03-2002	Williams et al.	705/26
*	D	US-2004/0024660 A1	02-2004	GANESH et al.	705/28
*	E	US-2004/0024658 A1	02-2004	Carbone et al.	705/28
*	F	US-6,463,420 B1	10-2002	Guidice et al.	705/28
*	G	US-2006/0053027 A1	03-2006	Riggs et al.	705/001
*	H	US-2008/0183526 A1	07-2008	Hancock et al.	705/7
*	I	US-2002/0116241 A1	08-2002	Sandhu et al.	705/7
*	J	US-2008/0040144 A1	02-2008	RIGGS et al.	705/001
*	K	US-7,191,142 B1	03-2007	Sandell et al.	705/9
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.